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Last)	Dayton, OH 45444-5270		7. CAGE CODE 67268	8. DOCUMENT NO. 5962-89641
9. TITLE OF DOCUMENT	· · · ·	10. REVISION LET	ITER	11. ECP NO.
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 CHECK ONE [X] EXISTING DOCUMENT SUPPLEMENTED [BY THIS NOR MAY BE USED IN MANUFACTURE.] REVISED DOCUMENT MUST BE [] RECEIVED BEFORE MANUFACTURER MAY INCORPORATE THIS CHANGE.	CUSTODIAN OF MASTER DOCUM SHALL MAKE ABOVE REVISIO FURNISH REVISED DOCUMENT	n and						
b. ACTIVITY AUTHORIZED TO APPROVE CHANGE FOR GOVERNMENT DESC-ECS	SIGNATURE AND TITLE Michael A Frye Branch Chief	DATE (YYMMDD) 93-03-18							
12. ACTIVITY ACCOMPLISHING	REVISION COMPLETED (Signature)	DATE (YYMMDD)							
REVISION DESC-ECS	Marcia B Kelleher	93-03-18							

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DISTRIBUTION STATEMENT A. Approved for public release; distribution is unlimited.

1. SCOPE			
1.1 <u>Scope</u> . This drawing describes device requirements MIL-STD-883, "Provisions for the use of MIL-STD-883 in con	for class B mic junction with co	rocircuits in accordance wi ompliant non-JAN devices".	th 1.2.1 of
1.2 Part or Identifying Number (PIN). The complete PIN	shall be as she	own in the following exampl	e:
<u>5962-89641</u> 01	<u>c_</u>	<u>- X</u>	
		Land finish pan	
	outline 2.2)	Lead finish per MIL-M-38510	
1.2.1 <u>Device type(s)</u> . The device type(s) shall identif	y the circuit f	unction as follows:	
Device type <u>Generic number</u>	Circui	t function	
01 AD841 Unity-gai	n stable, fast	settling operational amplif	ier
1.2.2 <u>Case outline(s)</u> . The case outline(s) shall be as	designated in	MIL-STD-1835 and as follows	:
Outline letter Descriptive designator	Terminals	Package style	
C GDIP1-T14 or CDIP2-T14	14 12	Dual-in-line Can	
X See figure 1 2 CQCC1-N2O	20	Square leadless chip carrier	
1.3 <u>Absolute maximum ratings</u> . <u>1</u> / <u>2</u> /			
Voltage between V+ and V- terminals		36 V dc	
Differential input voltage		V+ to V-	
Peak output current (< 10% duty cycle) Storage temperature range		100 mA -65°C to +150°C	
Power dissipation (P _D): Case C		1.3 W 3/	
Case X		1.5 W <u>3</u> /	
Case 2		1.0 W <u>3</u> / +300°c	
Thermal resistance, junction-to-case (θ_{JC}) : Cases C and X		30°c/w	
Cases C and X	·	35°C/W	
Thermal resistance, junction-to-ambient (θ_{JA}) :		110°c/w	
Case C		100°c/W	
Case 2		150°C/₩ +175°C	
Sunction temperature $(1_j) = $		+175 C	
<u>1</u> / Stresses above the absolute maximum rating may cause operation at the maximum levels may degrade performance			
$\underline{2}/T_{A} = +25^{\circ}C$ unless otherwise noted.			
<u>3</u> / Derate linearly above T _A = +25°C for case C at 8.7 m at 6.7 mW/°C.	W/°C, case X at	∶10 mW/°C, and case 2	
STANDARDIZED	SIZE		5962-89641
MILITARY DRAWING	A		5702-07041
DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444	······································	REVISION LEVEL	SHEET
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1.4 <u>Recommended operating conditions</u>.

Positive supply voltage range (V+)	+5 V dc to +15 V dc
Negative supply voltage range (V-)	-5 V dc to -15 V dc
Common mode input voltage (V _{CM})	±10 V
Load resistance (R,)	500Ω
Ambient operating temperature range (T _A)	-55°C to +125°C

2. APPLICABLE DOCUMENTS

2.1 <u>Government specification, standard, and bulletin</u>. Unless otherwise specified, the following specification, standard, and bulletin of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510 - Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883	-	Test Methods and Procedures for Microelectronics.
MIL-STD-1835	-	Microcircuit Case Outlines.

BULLETIN

MILITARY

MIL-BUL-103 - List of Standardized Military Drawings (SMD's).

(Copies of the specification, standard, and bulletin required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

2.2 <u>Order of precedence</u>. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.

3. REQUIREMENTS

3.1 <u>Item requirements</u>. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.

3.2 <u>Design, construction, and physical dimensions</u>. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.

3.2.1 Case outline(s). The case outline(s) shall be in accordance with 1.2.2 herein and figure 1.

3.2.2 <u>Terminal connections</u>. The terminal connections shall be as specified on figure 2.

3.3 <u>Electrical performance characteristics</u>. Unless otherwise specified herein, the electrical performance characteristics are as specified in table I and shall apply over the full ambient operating temperature range.

3.4 <u>Electrical test requirements</u>. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are described in table I.

STANDARDIZED MILITARY DRAWING	SIZE A		5962-89641
DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444		REVISION LEVEL	SHEET 3

Test	Symbol	Conditions <u>1</u> -55°C ≤ T _A ≤ +125 V± = ±15 V	Group A C subgroups		s <u>2</u> /	Unit
······································		V± = ±15 V unless otherwise spe		Min	Max	
Input offset voltage	 v ₁₀	V _{CM} = 0 V	1	-2.0	+2.0	mV
			2, 3	-5.5	+5.5	
Input bias current	+1 ₈	v _{cm} = 0 v	1		+8	<i>µ</i> A
			2, 3		+12	_
	 -I _B	v _{cm} = 0 v	11	-8	 	
			2, 3		 	
Input offset current	I IO	v _{cm} = 0 v	1		+0.4	μA
	<u> </u>		2, 3		+0.6	
Common mode voltage range	^{+∨} см	V+ = 5.0 V, V- = -25 V, V _{OUT} = -10 V	, 1, 2, 3	10		v
	^{−V} cm	 v+ = 25 v, v- ≃ -5.0 v, v _{out} = 10 v	,		-10	
Large signal voltage gain	+A _{VOL}	$ V_{OUT} = 0 V \text{ and } 10 V,$ $ R_L = 500\Omega$	11	25	1	V/mV
	R _L = 500Ω	2, 3	12	 		
	 -A _{VOL}	 V _{OUT} = 0 V and -10 V, R _L = 500Ω	1	25	 	
		R ⁰ = 500Ω	2, 3	12	 	
Output current	+I _{OUT}	V _{OUT} = -10 V, T _A = +25	°c 1	50	 	mA
	⁻¹ out	V _{OUT} = +10 V, T _A = +25	°c		-50	
Output voltage swing	+V _{OUT}	 R _L = 500Ω	1, 2, 3	10		v
	-V _{OUT}	R _L = 500Ω			 –10	
Quiescent power supply	+Icc	 V _{OUT} = 0 V, I _{OUT} = 0 m	A <u>1</u>		+12	mA
current			2, 3		+16	
	-I _{cc}	$V_{OUT} = 0 V, I_{OUT} = 0 m$	A <u>1</u>	-12		
			2, 3	-16	 	
ee footnotes at end of ta	able.					
STANDARDIZED MILITARY DRAWING			SIZE A		59	62-8964

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		Conditions $-55^{\circ}C \leq T_{A} \leq +12$ $V \pm = \pm 15 V$	<u>1</u> / 5°c	Group A subgroups	Limits 	<u>2</u> /	Unit
	ļ	unless otherwise sp		<u> </u>	Min	Max	
Yower supply rejection ratio	+PSRR	V+ = 5.0 V to 18 V, V-	= -15 V	1	86		dB
ratio			· · · · · · · · · · · · · · · · · · ·	2, 3	80		+
	-PSRR	$V_{-} = -5.0 V$ to $-18 V$,	v+ = +15 v	11	86		ļ
	<u> </u>			2, 3	80		1
Quiescent power	P _C	$ V_{OUT} = 0 V, I_{OUT} = 0 m$	A	1		360	mW
consumption <u>3</u> /				2, 3		480	
Common mode rejection	+CMRR	 Delta V _{CM} = 10 V, V+ =	$v_{\rm ev} = 10 v_{\rm e} v_{\rm f} = 5.0 v_{\rm e}$		86		⊥dB
ratio	ĺ	Delta V _{CM} = 10 V, V+ = V- = -25 V, V _{OUT} = -10	V	5,6	80		
	-CMRR	Delta $V_{cu} = -10 V_{c} V_{+}$	= 25 V,	4	86		1
		Delta V _{CM} = -10 V, V+ V- = -5.0 V, V _{OUT} = 10	v	5,6	80		
Differential input resistance <u>4</u> /	RIN	V _{CM} = 0 V, T _A = +25°C		4	65		 kΩ
Gain bandwidth product <u>4</u> /	GBWP	$V_{OUT} = \pm 100 \text{ mV}, R_L = 500\Omega,$ f ₁ = 100 kHz, f ₂ = 10 MHz, T _A = +25°C		4	23		MHz
Full power bandwidth <u>4</u> / <u>5</u> /	FPBW	$V_{PK} = 10 V, R_{L} = 500\Omega$ $T_{A} = +25°C$	$V_{PK} = 10 V, R_{L} = 500\Omega$ $T_{A} = +25°C$		3.1		MHz
Closed loop stable gain	CLSG	$ R_{L} = 500\Omega, C_{L} \le 10 \text{ pF}$		4, 5, 6	1		v/v
Slew rate <u>4</u> /	+SR	$ V_{OUT} = -5.0 \text{ V to } 5.0 \text{ V}$ $ R_L = 500\Omega, A_V = -1 \text{ V/V}$, measured	4	220		V/µs
	 	from 10% to 90% point, edge	rising	5,6	140		
	-SR	$ V_{OUT} = 5.0 V \text{ to } -5.0 V$ $R_{L} = 500\Omega, A_{V} = -1 V/V$ from 90% to 10% point,	/, /, measured	4	220		
		from 90% to 10% point, edge 	falling	5,6	140		

Test	Symbol	Conditions $1/$ -55°C $\leq T_A \leq +125°C$	Group A subgroups _	Limi	ts <u>2</u> /	Unit
		V± = ±15 V unless otherwise specified		Min	Max	
Rise time <u>4/6</u> /	^t R	$V_{OUT} = 0 V$ to +200 mV, $R_L = 500\Omega$, $A_V = +1$	9, 10, 11		10	 ns
Fall time <u>4/6</u> /	tF	$V_{OUT} = 0$ V to -200 mV, R _L = 500 Ω , A _V = +1	9, 10,		10	ns
Settling time <u>4</u> /	lt _s	$A_V = -1 V/V$, 10 V step at 0.1% of the final value, $R_L = 500\Omega$, $ T_A = +25^{\circ}C$	9		150	ns
		$A_V = -1 V/V$, 10 V step at 0.01% of the final value, $R_L = 500\Omega$, $T_A = +25°C$			200	
Overshoot <u>4</u> /	+0S	$V_{OUT} = 0 V to +200 mV, A_V = +1, R_L = 500 \Omega, T_A = +25°C$	9		40	%
	-0S	 $V_{OUT} = 0 V \text{ to } -200 \text{ mV}, A_V = +1,$ $R_L = 500 \Omega, T_A = +25^{\circ}\text{C}$			40	

TABLE I. <u>Electrical performance characteristics</u> - Continued.

 $\underline{1}/$ Unless otherwise specified, for dc tests, R_{L} = 100 k Ω and V_{OUT} = 0 V.

2/ The algebraic convention, whereby the most negative value is a minimum and the most positive is a maximum, is used in this table. Negative current shall be defined as conventional current flow out of device terminal.

 $\underline{3}$ / Quiescent power consumption is based on quiescent supply current test maximum with no load on outputs.

4/ If not tested, shall be guaranteed to the limits specified in table I herein.

 $\frac{5}{2 \pi V_{PK}}$.

6/ Rise and fall times measured between 10 percent and 90 percent point.

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DAYTON, OHIO 45444		REVISION LEVEL	SHEET 6

	*D1				ANE	$ \begin{array}{c} & \bullet & \bullet & \bullet \\ & \bullet & \bullet & \bullet $									
	G - K 1 SEATING PLANE														
Symbol	Inc	hes:	 Milli	meters	Notes										
	Min	Max	Min	Max	Ī										
A	.148	. 181	3.76	4.60	1										
¢b	 016	.019	0.41	0.48	1	1									
¢b ₁	.016	.021	0.41	0.53	 1 										
φ 0	.592	.615	15.04	15.62											
φ0 ₁	.545	. 555	13.84	14.10	 										
e	.400	BSC	10.16	BSC	3	NOTES:									
• ₁	.200	BSC	5.00	BSC	3	1. All leads ϕ b applies between L and L ₁ . ϕ b1 applies between L ₁ and .375 inch (9.52 mm) from the reference plane.									
e ₂	. 100	BSC	2.54	BSC	3	2. Measured from the maximum diameter of the product. 3. Leads having a maximum diameter .019 inch									
	 	.040	1	1.02		(0.48 mm) measured in gauging plane .054 inc (1.37 mm) +.001 inch (0.03 mm)000 inch									
	.026	.036	0.66	0.91		(0.000 mm) below the base plane of the produce of t	ct								
k1	.027	.037	0.68	0.94	2	position relative to the maximum width tab.									
	.375		9.50	1											
		.050		1.27	1										
Q	.010	.045	0.25	1.14											
			4	F IGU	RE 1. <u>C</u>	ase outline X.									
	MILI	ANDARDI TARY DI	RAWING			SIZE 5962-8964	41								
DEFEN	SE ELECT DAYTON	RONICS 1, OHIO	SUPPLY 45444	Y CENTE 4	R	REVISION LEVEL SHEET 7									

Device type	01			
Case outlines	с	x	2	
Terminal number	Terminal symbol			
1	NC	NC	NC	
2	NC	NC	BALANCE	
3	BALANCE	BALANCE	NC	
4	INPUT-	BALANCE	NC	
5	INPUT+	INPUT-	INPUT-	
6	V-	INPUT+	NC	
7	NC	NC	INPUT+	
8	NC	NC	NC	
9	NC	NC	NC	
10	OUTPUT	V-	۷-	
11	V+	OUTPUT	NC	
12	BALANCE	V+	NC	
13	NC		NC	
14	NC		NC	
15			OUTPUT	
16			NC	
17			V+	
18			NC	
19			NC	
20			BALANCE	

.

FIGURE 2. <u>Terminal connections</u>.

STANDARDIZED MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444	SIZE A		5962-89641
		REVISION LEVEL	SHEET 8

DESC FORM 193A JUL 91 3.5 <u>Marking</u>. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the PIN listed in 1.2 herein. In addition, the manufacturer's PIN may also be marked as listed in MIL-BUL-103 (see 6.6 herein).

3.6 <u>Certificate of compliance</u>. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in MIL-BUL-103 (see 6.6 herein). The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall affirm that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.

3.7 <u>Certificate of conformance</u>. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.

3.8 <u>Notification of change</u>. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).

3.9 <u>Verification and review</u>. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.

4. QUALITY ASSURANCE PROVISIONS

4.1 <u>Sampling and inspection</u>. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).

4.2 <u>Screening</u>. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:

- a. Burn-in test, method 1015 of MIL-STD-883.
 - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.6 herein).
 - (2) $T_A = +125^{\circ}C$, minimum.
- b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.

4.3 <u>Quality conformance inspection</u>. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.

4.3.1 Group A inspection.

- a. Tests shall be as specified in table II herein.
- b. Subgroups 7 and 8 in table I, method 5005 of MIL-STD-883 shall be omitted.
- 4.3.2 Groups C and D inspections.
 - a. End-point electrical parameters shall be as specified in table II herein.
 - b. Steady-state life test conditions, method 1005 of MIL-STD-883.
 - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.6 herein).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

STANDARDIZED MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444	SIZE A		5962-89641
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MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004)	1,4
Final electrical test parameters (method 5005)	1*,2,3,4
Group A test requirements (method 5004)	 1,2,3,4,5,6,9**, 10**,11**
Groups C and D end-point electrical parameters (method 5005)	1

TABLE II. Electrical test requirements.

* PDA applies to subgroup 1.

** Subgroups 9, 10, and 11 shall be measured only for initial test and after process or design changes and shall be guaranteed to the limits specified in table I.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

6. NOTES

6.1 <u>Intended use</u>. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.

6.2 <u>Replaceability</u>. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.

6.3 <u>Configuration control of SMD's</u>. All proposed changes to existing SMD's will be coordinated with the users of record for the individual documents. This coordination will be accomplished in accordance with MIL-STD-481 using DD Form 1693, Engineering Change Proposal (Short Form).

6.4 <u>Record of users</u>. Military and industrial users shall inform Defense Electronics Supply Center when a system application requires configuration control and the applicable SMD. DESC will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronics devices (FSC 5962) should contact DESC-ECS, telephone (513) 296-6010.

6.5 <u>Comments</u>. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone (513) 296-5377.

6.6 <u>Approved sources of supply</u>. Approved sources of supply are listed in MIL-BUL-103. The vendors listed in MIL-BUL-103 have agreed to this drawing and a certificate of compliance (see 3.6 herein) has been submitted to and accepted by DESC-ECS.

STANDARDIZED MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444	SIZE A		5962-89641
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